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UTILITY PATENT APPLICATION TRANSMITTAL <small>(Only for new nonprovisional applications under 37 C.F.R. 1.53(b))</small>	Attorney Docket No.	2789.2004-001
	First Named Inventor or Application Identifier	William J. Dally
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Title of Invention	Transition-Time Control In A High-Speed Data Transmitter
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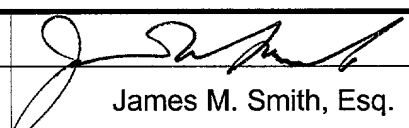
APPLICATION ELEMENTS See MPEP chapter 600 concerning utility patent application contents.	ADDRESS TO: Assistant Commissioner for Patent Box Patent Application Washington, D.C. 20231
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1. <input checked="" type="checkbox"/> Fee Transmittal Form <i>(Submit an original, and a duplicate for fee processing)</i> 2. <input checked="" type="checkbox"/> Specification [Total Pages [22]] <i>(preferred arrangement set forth below)</i> - Descriptive title of the invention - Cross References to Related Applications - Statement Regarding Fed sponsored R & D - Reference to microfiche Appendix - Background of the Invention - Summary of the Invention - Brief Description of the Drawings - Detailed Description - Claim(s) - Abstract of the Disclosure 3. <input checked="" type="checkbox"/> Drawing(s) (35 U.S.C. 113) [Total Sheets [8]] <input checked="" type="checkbox"/> Formal <input type="checkbox"/> Informal 4. <input checked="" type="checkbox"/> Oath or Declaration/POA [Total Pages [3]] a. <input checked="" type="checkbox"/> Newly executed (original or copy) b. <input type="checkbox"/> Copy from a prior application (37 C.F.R. 1.63(d)) <i>(for continuation/divisional with Box 17 completed)</i> [NOTE Box 5 below] i. <input type="checkbox"/> <u>DELETION OF INVENTOR(S)</u> Signed statement attached deleting inventor(s) named in the prior application, see 37 C.F.R. 1.63(d)(2) and 1.33(b). 5. <input type="checkbox"/> Incorporation By Reference <i>(useable if Box 4b is checked)</i> The entire disclosure of the prior application, from which a copy of the oath or declaration is supplied under Box 4b, is considered as being part of the disclosure of the accompanying application and is hereby incorporated by reference therein.	6. <input type="checkbox"/> Microfiche Computer Program <i>(Appendix)</i> 7. <input type="checkbox"/> Nucleotide and/or Amino Acid Sequence Submission <i>(if applicable, all necessary)</i> a. <input type="checkbox"/> Computer Readable Copy b. <input type="checkbox"/> Paper Copy (identical to computer copy) [] Pages c. <input type="checkbox"/> Statement verifying identity of above copies
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ACCOMPANYING APPLICATION PARTS	
8. <input checked="" type="checkbox"/> Assignment Papers (cover sheet & documents) 9. <input type="checkbox"/> 37 C.F.R. 3.73(b) Statement <input type="checkbox"/> Power of Attorney <i>(when there is an assignee)</i> 10. <input type="checkbox"/> English Translation Document <i>(if applicable)</i> 11. <input type="checkbox"/> Information Disclosure Statement (IDS)/PTO-1449 <input type="checkbox"/> Copies of IDS Citations 12. <input type="checkbox"/> Preliminary Amendment 13. <input checked="" type="checkbox"/> Return Receipt Postcard (MPEP 503) <i>(Should be specifically itemized)</i> 14. <input type="checkbox"/> Small Entity Statement(s) <input type="checkbox"/> Statement filed in prior application, status still proper and desired 15. <input type="checkbox"/> Certified Copy of Priority Document(s) <i>(if foreign priority is claimed)</i> 16. <input type="checkbox"/> Other: _____	

17. If a CONTINUING APPLICATION , check appropriate box and supply the requisite information: <input type="checkbox"/> Continuation <input type="checkbox"/> Divisional <input type="checkbox"/> Continuation-in-part (CIP) of prior application No.: Prior application information: Examiner: Group Art Unit:

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Inventors: William J. Dally and John W. Poulton
Attorney's Docket No.: 2789.2004001

TRANSITION-TIME CONTROL IN A HIGH-SPEED DATA TRANSMITTER

RELATED APPLICATION(S)

This application claims the benefit of U.S. Provisional Application No. 60/181,276, filed February 9, 2000, the entire teachings of which are incorporated
5 herein by reference.

BACKGROUND OF THE INVENTION

The transition time, rise time or fall time, of an output driver is the time required for the output signal to slew between two voltages, typically 20% and 80% of full swing. In certain prior-art systems, for example, transition time must be maintained
10 larger than a specified minimum value to keep the derivative of the supply current, and hence the inductive switching noise (sometimes called simultaneous switching output (SSO) noise), within limits. At the same time, transition time must be kept smaller than a maximum value to avoid excessive delay of the signal.

Across variations in process parameters, supply voltage, and temperature,
15 transition time can vary by a considerable amount, often by a factor of two or more. In some applications, the spread between maximum and minimum values for transition time is wide enough so that this variation is acceptable. In other applications, however, the window of legal transition times is small and such a large variation in transition time is unacceptable.

20 Transition time control has been employed in prior art systems with relatively slow signaling rates, where the bit time is greater than 10 gate delays. At such data rates, transition time can be controlled by using a tapped delay line to sequence the

stages of a segmented transmitter or by slowing the predriver stage of a transmitter. These techniques are discussed in Dally and Poulton, *Digital Systems Engineering*, Cambridge, pages 533-536.

Still other prior art systems have employed transition time control by controlling the transition time of a pre-driver which, in turn, controls the transition time of the output driver. The pre-driver transition time may be controlled by varying its supply voltage, controlling its supply current, or enabling a variable number of parallel pre-driver elements. As explained in Dally and Poulton, pp 533-536, slowing the transition time of the pre-driver in this manner can lead to severe inter-symbol interference, especially at high signaling rates. Because the output stage typically has significant gain, the predriver must be made very slow to give an output transition time that is a substantial fraction of a bit time. Often the pre-driver is so slow that it is not able to swing full-rail before the end of the bit time leading to significant inter-symbol interference due to the retained state.

In systems that operate at fast signaling rates, where the bit time is just a few loaded gate delays (less than 10), neither of these prior art transition control mechanisms is applicable. The transition time in such high-speed systems is just a few gate delays (less than 3) and thus comparable to the delay of a single tap of a tapped delay line. Because the entire transition must occur in just one (or at most two) taps of the delay line, it is not possible to smoothly sequence the transition by using a tapped delay line to sequence transmitter segments.

In such high-speed systems, the transition time is typically a large fraction of the bit time (usually 30%-50%). This is because a faster transition time would stress the bandwidth of the transmission medium (package, PC board, and connectors) without offering any substantial advantage. With such a ratio of transition time to bit time, it is not possible to control the transition time by slowing the predriver. To do so would require the predriver to have a delay much longer than the bit time and thus would cause intersymbol interference.

Because of these limitations, prior-art high-speed signaling systems have not employed transition time control and, as a result, have incurred large variations in transition time across process, voltage, and temperature corners.

SUMMARY OF THE INVENTION

5 In accordance with one aspect of the invention, a data transmitter comprises a data input and plural delay elements. The delay elements apply different delays to the data input in parallel to provide plural delayed data signals. A data output combines the delay and data signals so that a transition time of the data output is determined by difference in delays applied to the data input.

10 Prior art transition control systems controlled the transition time to be a fixed value, regardless of the bit time of the system. With a fixed transition time, a signaling system operating at a lower speed is forced to use a transition time optimized for the highest possible speed of operation, unduly stressing the bandwidth of the transmission medium.

15 In accordance with another aspect of the invention, transition time control controls the transition time of a controlled data signal to be proportional to bit time of a bit clock.

A clock signal may be applied to the delay elements, with different delays being applied to the data input by clocking the data input with different delayed clock signals.

20 Alternatively, the data input may be applied in parallel directly to the delay element. In either case, the delayed data signals are applied to plural driver circuits. Preferably, each delay element comprises CMOS inverters and the delay of the delay elements is determined by load capacitance.

Supply voltage to the delay elements may be controlled to control delay of the
25 delay elements. In one embodiment, a circuit to control the supply voltage to the delay elements comprises first and second delay elements, each receiving a common clock signal. A phase comparator compares outputs of the first and second delay elements and controls a supply voltage applied to the first and second delay elements to control

phase difference of the outputs. Each of the first and second delay elements may comprise a sequence of n elements and the clock signal frequency may then be $1/n$ times bit rate. The supply voltage may thus be varied to compensate for environmental changes in delay.

5 BRIEF DESCRIPTION OF THE DRAWINGS

The foregoing and other objects, features and advantages of the invention will be apparent from the following more particular description of preferred embodiments of the invention, as illustrated in the accompanying drawings in which like reference characters refer to the same parts throughout the different views. The drawings are not necessarily to scale, emphasis instead being placed upon illustrating the principles of the invention.

Figure 1 illustrates an embodiment of the invention in which a clock signal is applied to delay elements and the data input is clocked with different delayed clock signals.

Figure 2 is a timing chart for the circuit of Figure 1.

Figure 3 illustrates an embodiment of the invention in which the input data is delayed directly in parallel delay elements.

Figure 4 is a timing chart for the circuit of Figure 3.

Figure 5 illustrates an array of delay elements for use in either Figure 1 or Figure 3.

Figure 6 illustrates a circuit to control the supply voltage to the delay element of Figure 5.

Figure 7 illustrates a modification of the circuit of Figure 6 for operation with a slow multiplexing clock.

Figure 8 illustrates an array of delay elements including serial/parallel connections of delay elements.

DETAILED DESCRIPTION OF THE INVENTION

A description of preferred embodiments of the invention follows.

In a high-speed transmission system, where the bit time is less than 4 gate delays, prior art approaches to controlling rise time do not apply. A tapped delay line cannot be used since the desired transition time is comparable to the delay of a single tap. Slowing the predriver is also not appropriate as it will result in considerable ISI as the slow predriver stage will not reach a steady state before the end of each bit cycle.

The present invention overcomes these limitations and controls the rise time of a high-speed transmitter by segmenting the transmitter and driving each segment with a variable delay element driven from a common clock node. By appropriately adjusting the delays of the variable delay elements the segment switching times can be set at intervals that are a small fraction of a gate delay resulting in a controlled transition time comparable to a single gate delay. With this approach the timing resolution is set by the difference between element delays rather than by the delay of a single element. This gives a granularity of timing control fine enough to handle the fastest signaling systems.

In high-speed signaling systems it is advantageous to control the transition time to be not a fixed interval, but rather a fraction of the bit-time (e.g., 40%). With this approach, a signaling system operating at a lower speed (with a longer bit time) would use a proportionally longer transition time. Hence it requires less bandwidth out of the transmission medium and can use less expensive materials and components in constructing the transmission system. At very low signaling rates, of course, the transition time is maintained less than a fixed maximum to avoid noise problems that occur with very slow transition times.

The present invention achieves this variable bandwidth advantage by controlling transition time to be a fraction of the bit time. This is accomplished by adjusting the variable delay elements so the difference in delay between the slowest element and fastest element is equal to the desired fraction of a clock cycle.

A block diagram of an embodiment of the present invention is illustrated in Figure 1. The figure illustrates a segmented output driver with transition control. The

driver accepts data on line 101 and an input clock on line 102. The input clock is delayed by four delay elements 121-124 with delays t_{d1} to t_{d4} to generate sequencing clocks c1 to c4 on lines 103-106. These sequencing clocks are used to clock the input data into four flip-flops 125-128. The outputs of the flip-flops, d1-d4 on lines 107-110, are input to current drivers 129-132. The current drivers sum their currents onto output line 111 so that the current waveform on this line is the superposition of the currents from the four current drivers.

The block diagram of Figure 1 is best understood with reference to the waveforms of Figure 2. The top trace shows the data input line 101 which rises at the beginning of the trace and remains high during the valid window when it is being sampled by sequencing clocks c1 to c4. One skilled in the art of digital design will understand that the data input signal is preconditioned using latches to guarantee that it is stable during this valid window. The second trace shows the input clock, ck on line 102. The next four traces show the sequencing clocks c1 to c4 on lines 103-106. The delay of each element is slightly different with delay element 121 having the smallest delay and delay element 124 having the largest delay. The delay increases by a fixed amount per element to give four evenly spaced sequencing clocks. The figure illustrates how these parallel delay elements can generate sequencing clocks with a spacing, Δt_d , that is much less than the delay of the fastest element, t_{d1} . The spacing is set by the difference between the delay of two elements, $\Delta t_d = t_{d2} - t_{d1}$. This is in contrast to prior art transition time control systems based on tapped delay lines where the spacing of sequencing clocks must be at least as large as the delay of an element, t_d .

The next four traces, traces 7 through 10, show the outputs d1'-d4' of the individual current drivers 129-132 before they are summed on the line. For clarity in the figure we have shown these signals with an unrealistically short delay from the clock inputs of the flip flops to the corresponding outputs of the current drivers (e.g., from c1 on line 103 to the output of current driver 129). In practice there would be a much larger delay between these two signals. However the causality of the signals is easier to appreciate with the waveforms as drawn in Figure 2.

The rise time of an individual current driver, t_{r1} , is designed to be comparable to the spacing of the sequencing clocks, Δt_d , to ensure a smooth transition of the summed signal. The final output of the driver, the summed signal on data output line 111 is shown in the final trace. It has a rise time that is equal to $3\Delta t_d + t_{r1}$.

5 Figure 3 shows a block diagram for an alternate embodiment of the present invention in which the data, rather than the clock is delayed by a parallel arrangement of delay elements. In this embodiment the data in signal on line 101 is aligned with the clock, ck on line 102, by flip-flop 142. The aligned data signal, d0 on line 141, is then input to the four delay elements 121-124 with delays t_{d1} to t_{d4} . In this case, the delay
10 elements directly generate the skewed data signals d1 to d4 on lines 107 to 110. As with the system of Figure 1, these data signals are then input to current drivers 129 to 132 which sum their outputs on data output line 111.

The embodiment of Figure 3 is advantageous in that it requires fewer flip-flops than the embodiment of Figure 1 and, thus, reduces clock loading. The embodiment of
15 Figure 1 is preferred, however, in cases where the sequencing clocks c1 through c4 can be shared across multiple output drivers.

The embodiment of Figure 3 can be better understood by reference to the waveforms of Figure 4. The first trace shows the data input, din on line 101, and the second trace shows the clock, ck on line 102. Because din is sampled by only a single
20 clock, ck on line 102, it need only be valid during a small timing window, as illustrated, about the rising edge of the clock to account for setup and hold time. This is in contrast to the wide timing window required for din in the embodiment of Figures 1 and 2.

The third trace shows the aligned data out of flip-flop 142, d0 on line 141. This is a version of the data signal aligned to the clock. As in Figure 3, we have purposely
25 shown the clock-to-Q delay of the flip-flop much shorter than is realistic to improve the clarity of the figure. In reality there would be a much longer delay between the rising edge of clock and the transition on d0.

The next four traces show the outputs of the four delay elements, d1 to d4 on lines 107 to 110. In this figure we show the inputs to the current sources while in

Figure 2 traces with the same labels showed the outputs of the current sources with slower rise times. These traces illustrate how the parallel combination of delay lines is able to sequence signals with time differences, Δt_d , that are substantially smaller than the minimum delay of a delay element, t_{d1} .

- 5 The final trace of Figure 4 shows the data output signal. This is the superposition of the outputs of current drivers 129 through 132. As with the embodiment of Figures 1 and 2, the rise time of this signal is equal to $3\Delta t_d + t_{r1}$.

- One skilled in the art will understand that a high-speed driver with transition time control can be realized with many variations on the block diagrams of Figures 1 and 3. For example the driver may have a greater or smaller number of segments than the four segments shown in Figure 1. The output drivers may be voltage mode rather than current mode. Also, the drivers may be differential rather than single ended. The flip flops of Figure 1 may be replaced by latches, multiplexers, or a combination of latches, flip-flops, and multiplexers that aligns the data with the sequencing clocks.
- 10 Finally, the sequencing clocks may be generated with a combination of series and parallel delay elements or with such elements in combination with a multi-phase clock or a clock generated by an array oscillator.

- Figure 8 illustrates an alternative array of delay elements in which parallel delays are obtained through serial/parallel connections of delay elements. In particular, of four delays, two are provided by connecting the parallel delays t_{d1} and t_{d2} in series with a common delay element t_{d3} .

- One embodiment of the array of delay elements 121-124 of Figures 1 and 3 is illustrated in Figure 5. Each delay element comprises a pair of inverters. Other than the first element, each element also includes a capacitor to increase the delay of the element. For example, delay element 122 comprises inverters 153 and 160, and the output of inverter 153 is loaded by capacitor 156 with a capacitance of C . Subsequent delay elements use proportionally larger capacitors. Delay element 123 has a capacitor 157 with value $2C$, and element 124 has capacitor 158 with value $3C$.

The delay of a CMOS inverter increases in proportion to its output capacitance according to the formula, $t_d = t_{d0} + Ct_c$. In this formula t_{d0} is the delay of an inverter with no output load and t_c is the increase in inverter delay per unit of output load capacitance. Thus, the delay of element 121 in Figure 5 is $t_{d1} = t_{d0} + C_p t_c$ where C_p is the parasitic element of the intermediate node of the delay element. The delay of element 122 is $t_{d2} = t_{d0} + (C_p + C)t_c = t_{d1} + Ct_c$. Delay element 123 has delay $t_{d3} = t_{d0} + (C_p + 2C)t_c = t_{d2} + Ct_c$, and delay element 124 has delay $t_{d4} = t_{d0} + (C_p + 3C)t_c = t_{d3} + Ct_c$. Because the capacitance is increased by a fixed amount, C , at each stage, the delay also increases by a fixed amount, $\Delta t_d = Ct_c$ at each stage. The capacitance, C , is chosen so the increment in delay, $\Delta t_d = Ct_c$, is the required fraction of the bit time.

To compensate for the variation in delay due to process, voltage, and temperature variation the delay of inverters 152-155 can be varied by varying the supply voltage of each inverter. The supply voltage of these inverters is separated from the main supply and tied to control voltage, v_{ctrl} on line 151, to facilitate this compensation. As will be explained below, this control voltage can also be used to make the variation in delay between elements, and hence the transition time of the output, proportional to the bit time.

One skilled in the art will understand that the delay elements 121-124 can be implemented in many ways. Element delay can be varied by varying the drive of each inverter rather than varying the capacitive load. Delay can also be varied by varying the current to each stage. A differential delay element can be used rather than a single-ended element. A different circuit topology, for example a source-coupled FET delay stage can be used in place of a CMOS inverter.

A circuit that both compensates the delay elements of Figure 5 for process, voltage, and temperature variations and at the same time adjusts the transition time to be proportional to bit time is illustrated in Figure 6. The circuit comprises two delay elements, 176 and 177, of the same type used in Figure 5, a phase comparator and charge pump, 170, and a voltage follower, 180. Delay element 176 has no additional capacitance while delay element 177 is loaded with a capacitor with capacitance mC .

The phase comparator and charge pump may be of any type. The preferred embodiment uses a combined phase comparator and charge pump as disclosed in pending patent U.S. patent application no. 09/414,761, filed October 7, 1999, by Dally et al. for Combined Phase Comparator and Charge Pump Circuit.

5 This circuit uses feedback to adjust the control voltage, v_{ctrl} on line 151, so that the difference in delay between delay element 176 and delay element 177 is exactly one cycle of clock ck , i.e., one bit clock cycle, t_{bit} . If the difference between the delay of the elements is less than t_{bit} , the rising edge of the delayed clock signal c_{xm} on line 179 will lead the rising edge (of the subsequent clock cycle) of the delayed clock signal c_{x1} on
10 line 178 and the charge pump will decrease the control voltage. Decreasing the control voltage increases both the overall delay of both delay elements and the difference in delay between the elements. Eventually, this feedback will bring the two clock edges into alignment at the point where the difference in delay is exactly equal to t_{bit} . Similarly, if the delay difference is greater than t_{bit} , signal c_{x1} will lead signal c_{xm} and
15 the charge pump will increase v_{ctrl} to reduce the delay and again bring the two signals into alignment.

When the control loop has converged, the transition time of the driver is set to $(4/m)t_{bit}$. Because delay element 176 has delay $t_{dc1} = t_{d0} + C_p t_c$ and delay element 177 has delay $t_{dc2} = t_{d0} + (C_p + mC)t_c$, the difference in delay between the two elements is
20 $\Delta t_{dc} = mCt_c$. When the loop has converged, this difference is equal to the bit time: $\Delta t_{dc} = t_{bit}$. Thus $t_{bit} = mCt_c$ and we have $\Delta t_d = Ct_c = t_{bit}/m$. Since the drivers of Figures 1 and 3 have a rise time of $t_r = 3\Delta t_d + t_{r1}$ or if $t_{r1} \sim \Delta t_d$, $t_r \sim 4\Delta t_d = (4/m)t_{bit}$. In the case where $m=10$, for example, the transition time is controlled to be 40% of the rise time.

To prevent the transition time from exceeding a maximum value when the bit
25 clock, ck , is run very slowly, a diode clamp 190 is placed on the output of the charge pump that prevents v_{ctrl} from being decreased below a minimum value. This limits the rise time to be no greater than the delay corresponding to this clamped value. The diode clamp may be implemented with a diode-connected MOSFET.

In a multiplexing transmitter, the fastest available clock signal has a period that is $t_{ck} = nt_{bit}$ where n is the multiplexing factor, typically between 2 and 20. The compensation circuit of Figure 6 can be modified to operate with such a slow multiplexing clock by placing multiple delay elements in series as illustrated in Figure 7 for the case where $n=2$. In this circuit, the upper path of identical delay elements 176 and 186 has a delay that is twice the delay of element 176. Similarly, the lower path of identical delay elements 177 and 187 has a delay that is twice the delay of element 177. Thus when the feedback brings nodes $cy1$ on line 188 and cym on line 189 into phase we have $2\Delta t_{dc} = t_{ck} = nt_{bit}$ or for the case where $n=2$, $\Delta t_{dc} = t_{bit}$ as desired. One skilled in the art will understand that a clock at n times the bit rate can be accommodated by placing n copies of delay element 176 in series on the upper clock path and n copies of delay element 177 in series on the lower clock path.

While this invention has been particularly shown and described with references to preferred embodiments thereof, it will be understood by those skilled in the art that various changes in form and details may be made therein without departing from the scope of the invention encompassed by the appended claims.

CLAIMS

What is claimed is:

1. A data transmitter comprising:
a data input;
5 plural delay elements applying different delays to the data input in parallel to provide plural delayed data signals; and
a data output combining the delayed data signals, a transition time of the data output being determined by difference in delays applied to the data input.
2. A data transmitter as claimed in claim 1 wherein plural of the delay elements are
10 parallel delay elements connected in series with a common delay element.
3. A data transmitter as claimed in claim 1 wherein a clock signal is applied to the delay elements and different delays are applied to the data input by clocking the data input with different delayed clock signals.
4. A data transmitter as claimed in claim 3 wherein the delayed clock signals
15 sequence the data input into plural driver circuits.
5. A data transmitter as claimed in claim 4 wherein each delay element comprises CMOS inverters.
6. A data transmitter as claimed in claim 5 wherein delay of the delay elements is determined by load capacitance.
- 20 7. A data transmitter as claimed in claim 1 wherein the data input is applied in parallel to the delay elements.

8. A data transmitter as claimed in claim 7 wherein the delayed data signals are applied to plural driver circuits.
9. A data transmitter as claimed in claim 8 wherein each delay element comprises CMOS inverters.
- 5 10. A data transmitter as claimed in claim 9 wherein delay of the delay elements is determined by load capacitance.
11. A data transmitter as claimed in claim 1 wherein the transition time of the data output is proportional to bit time.
12. A data transmitter as claimed in claim 1 wherein supply voltage to the delay
10 elements is controlled to control delay of the delay elements.
13. A data transmitter as claimed in claim 12 further comprising a circuit to control the supply voltage to the delay elements, the circuit comprising:
first and second delay elements, each receiving a common clock signal;
and
15 a phase comparator which compares outputs of the first and second delay elements and controls a supply voltage applied to the first and second delay elements to control phase difference of the outputs.
14. A data transmitter as claimed in claim 13 wherein each of the first and second
20 delay elements comprises a sequence of n elements and the clock signal frequency is $1/n$ times bit rate.
15. A data transmitter as claimed in claim 12 wherein the supply voltage is varied to compensate for environmental changes in delay.

16. A data transmitter as claimed in claim 1 further comprising a circuit to control the supply voltage to the delay elements, the circuit comprising:
first and second delay elements, each receiving a common clock signal;
and
5 a phase comparator which compares outputs of the first and second delay elements and controls a supply voltage applied to the first and second delay elements to control phase difference of the outputs.
17. A data transmitter as claimed in claim 16 wherein each of the first and second delay elements comprises a sequence of n elements and the clock signal
10 frequency is $1/n$ times bit rate.
18. A data transmitter comprising:
a data input;
a bit clock; and
transition time control receiving the data input and providing a controlled
15 data signal, the transition time control controlling the transition time of the controlled data signal to be proportional to bit time of the bit clock.
19. A data transmitter as claimed in claim 18 wherein a clock signal is applied to the delay elements and different delays are applied to the data input by clocking the data input with different delayed clock signals.
20. A data transmitter as claimed in claim 19 wherein the delayed clock signals
20 sequence the data input into plural driver circuits.
21. A data transmitter as claimed in claim 20 wherein each delay element comprises CMOS inverters.

22. A data transmitter as claimed in claim 21 wherein delay of the delay elements is determined by load capacitance.
23. A data transmitter as claimed in claim 18 wherein the data input is applied to the parallel delay elements.
- 5 24. A data transmitter as claimed in claim 23 wherein the delay data signals are applied to plural driver circuits.
25. A data transmitter as claimed in claim 24 wherein each delay element comprises CMOS inverters.
- 10 26. A data transmitter as claimed in claim 25 wherein delay of the delay elements is determined by load capacitance.
27. A data transmitter as claimed in claim 18 wherein supply voltage to the delay elements is controlled to control delay of the delay elements.
28. A data transmitter as claimed in claim 27 further comprising a circuit to control the supply voltage to the delay elements, the circuit comprising:
- 15 first and second delay elements, each receiving a common clock signal; and
- a phase comparator which compares outputs of the first and second delay elements and controls a supply voltage applied to the first and second delay elements to control phase difference of the outputs.
- 20 29. A data transmitter as claimed in claim 28 wherein each of the first and second delay elements comprises a sequence of n elements and the clock signal frequency is $1/n$ times bit rate.

30. A data transmitter as claimed in claim 27 wherein the supply voltage is varied to compensate for environmental changes in delay.
31. A data transmitter as claimed in claim 18 further comprising a circuit to control the supply voltage to the delay elements, the circuit comprising:
- 5 first and second delay elements, each receiving a common clock signal; and
- a phase comparator which compares outputs of the first and second delay elements and controls a supply voltage applied to the first and second delay elements to control phase difference of the outputs.
- 10 32. A data transmitter as claimed in claim 31 wherein each of the first and second delay elements comprises a sequence of n elements and the clock signal frequency is $1/n$ times bit rate.
33. A method of transmitting data comprising:
- applying different delays to a data input to provide plural delayed data
- 15 signals; and
- combining the plural delayed data signals to provide a data output having a transition time determined by difference in delays applied to the data input.
34. A method as claimed in claim 33 wherein the different delays are obtained by applying a first delay to the data input and further delaying in parallel delay
- 20 elements.
35. A method as claimed in claim 34 wherein a clock signal is applied to the delay elements and different delays are applied to the data input by clocking the data input with different delayed clock signals.

36. A method as claimed in claim 35 wherein the delayed clock signals sequence the data input into plural driver circuits.
37. A method as claimed in claim 36 wherein each delay is obtained in CMOS inverters.
- 5 38. A method as claimed in claim 37 wherein delay of the delay elements is determined by load capacitance.
39. A method as claimed in claim 34 wherein the data input is applied in parallel to the delay elements.
- 10 40. A method as claimed in claim 39 wherein the delay data signals are applied to plural driver circuits.
41. A method as claimed in claim 40 wherein each delay element comprises CMOS inverters.
42. A method as claimed in claim 41 wherein delay of the delay elements is determined by load capacitance.
- 15 43. A method as claimed in claim 33 wherein the transition time of the data output is proportional to bit time.
44. A method as claimed in claim 33 further comprising controlling supply voltage to the delay elements to control delay of the delay elements.
- 20 45. A method as claimed in claim 44 wherein the supply voltage to the delay elements is controlled by:

applying a common clock signal to first and second delay elements; and
comparing outputs of the first and second delay elements and controlling
the supply voltage applied to the first and second delay elements to control
phase difference of the output.

5 46. A method as claimed in claim 45 wherein each of the first and second delay
elements comprises a sequence of n elements and the clock signal is $1/n$ bit rate.

47. A method as claimed in claim 44 wherein the supply voltage is varied to
compensate for environmental changes in delay.

10 48. A method as claimed in claim 33 wherein the supply voltage to the delay
elements is controlled by:
applying a common clock signal to first and second delay elements; and
comparing outputs of the first and second delay elements and controlling
the supply voltage applied to the first and second delay elements to control
phase difference of the outputs.

15 49. A method as claimed in claim 48 wherein each of the first and second delay
elements comprises a sequence of n elements and the clock signal frequency is
 $1/n$ times bit rate.

20 50. A method of transmitting data comprising:
providing a bit clock;
receiving a data input; and
converting the data input to a controlled data signal having a controlled
transition time, the transition time of the controlled data signal being
proportional to bit time of the bit clock.

51. A method as claimed in claim 18 wherein a clock signal is applied to the delay elements and different delays are applied to the data input by clocking the data input with different delayed clock signals.
52. A method as claimed in claim 51 wherein the delayed clock signals sequence the data input into plural driver circuits.
53. A method as claimed in claim 52 wherein each delay element comprises CMOS inverters.
54. A method as claimed in claim 53 wherein delay of the delay elements is determined by load capacitance.
55. A method as claimed in claim 50 wherein the data input is applied in parallel to delay elements.
56. A method as claimed in claim 55 wherein the delay data signals are applied to plural driver circuits.
57. A method as claimed in claim 56 wherein each delay element comprises CMOS inverters.
58. A method as claimed in claim 57 wherein delay of the delay elements is determined by load capacitance.
59. A method as claimed in claim 50 further comprising controlling supply voltage to the delay elements to control delay of the delay elements.

60. A method as claimed in claim 59 wherein the supply voltage to the delay elements is controlled by:
- applying a common clock signal to first and second delay elements; and
comparing outputs of the first and second delay elements and controlling
5 the supply voltage applied to the first and second delay elements to control phase difference of the output.
61. A method as claimed in claim 60 wherein each of the first and second delay elements comprises a sequence of n elements and the clock signal frequency is $1/n$ times bit rate.
- 10 62. A method as claimed in claim 59 wherein the supply voltage is varied to compensate for environmental changes in delay.
63. A method as claimed in claim 50 wherein the supply voltage to the delay elements is controlled by:
- applying a common clock signal to first and second delay elements; and
15 comparing outputs of the first and second delay elements and controlling the supply voltage applied to the first and second delay elements to control phase difference of the outputs.
64. A method as claimed in claim 63 wherein each of the first and second delay elements comprises a sequence of n elements and the clock signal is $1/n$ times
20 bit rate.
65. A data transmitter comprising:
- a data input;
plural delay means for applying different delays to the data input to provide plural delayed data signals; and

data output means for combining the delayed data signals into a data output having a transition time determined by difference in delays applied to the data input.

66. A data transmitter comprising:

- 5 data input;
 a bit clock; and

transition time control means for providing a controlled data signal from the data input, the transition time of the controlled data signal being proportional to bit time of the bit clock.

TRANSITION-TIME CONTROL IN A HIGH-SPEED DATA TRANSMITTER

ABSTRACT OF THE DISCLOSURE

Transition time of a data signal is controlled by applying different delays to the data signal and combining the delayed data signals. The transition time of the data
5 output is determined by difference in delays applied to the data input and may be proportional to bit time of the bit clock. The data input may be applied directly to the delay elements or may be clocked by clock signals delayed by the delay elements. The delayed data is applied to parallel driver circuits. Supply voltage to the delay elements can be controlled to compensate for production and environmental variations. The
10 supply voltage controller includes parallel delay elements of different delays and a phase comparator, the output of which controls the supply voltage applied to the delay elements.

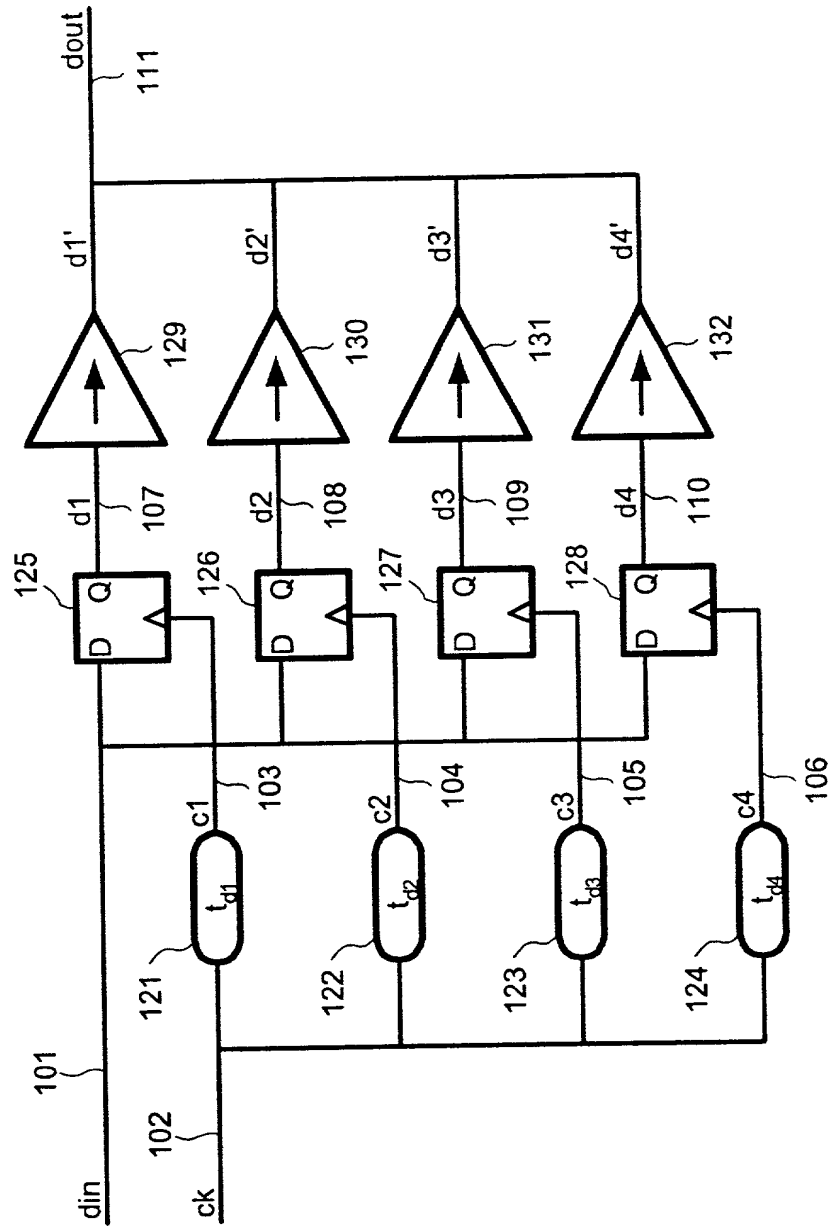


Figure 1

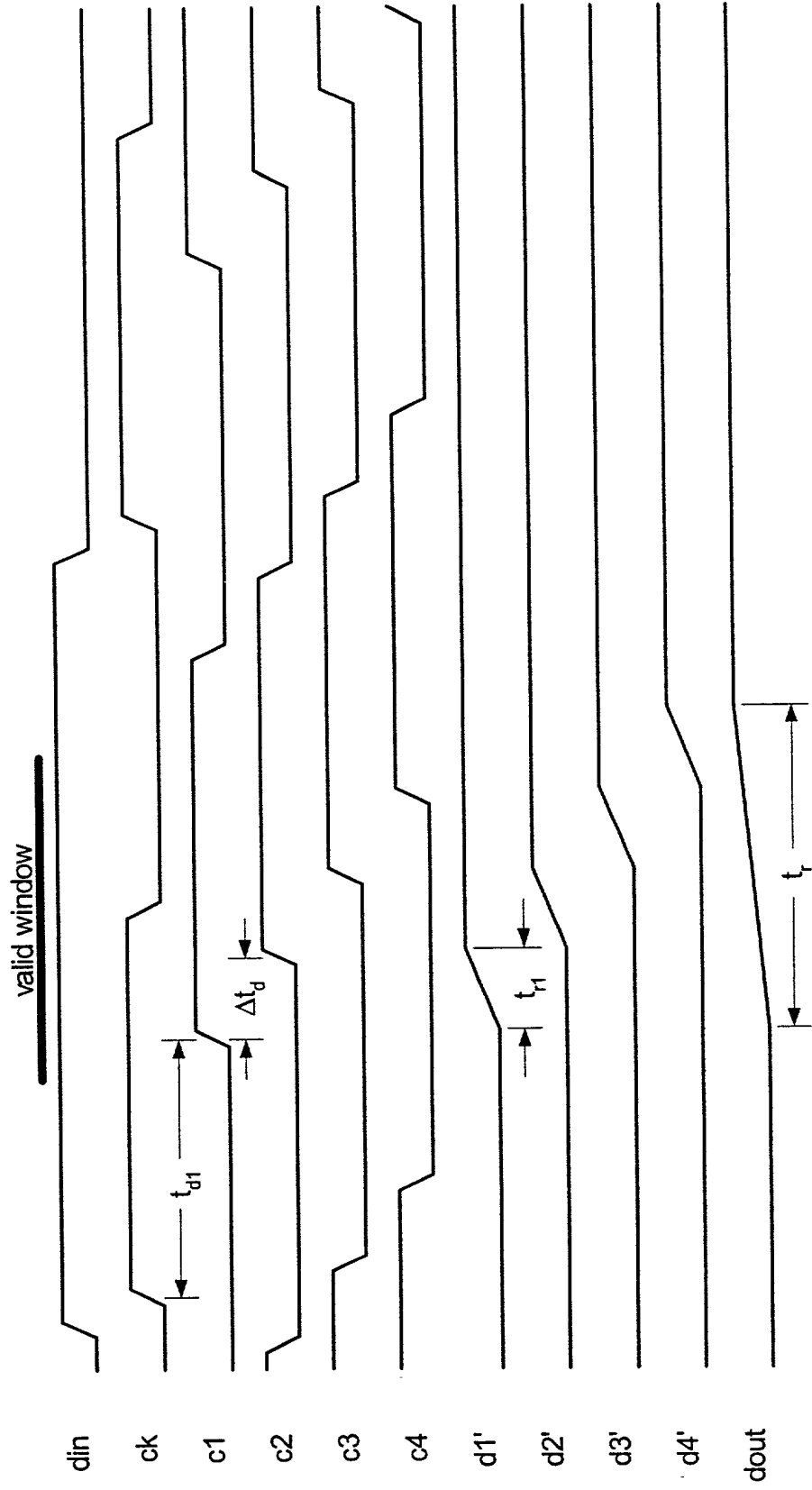


Figure 2

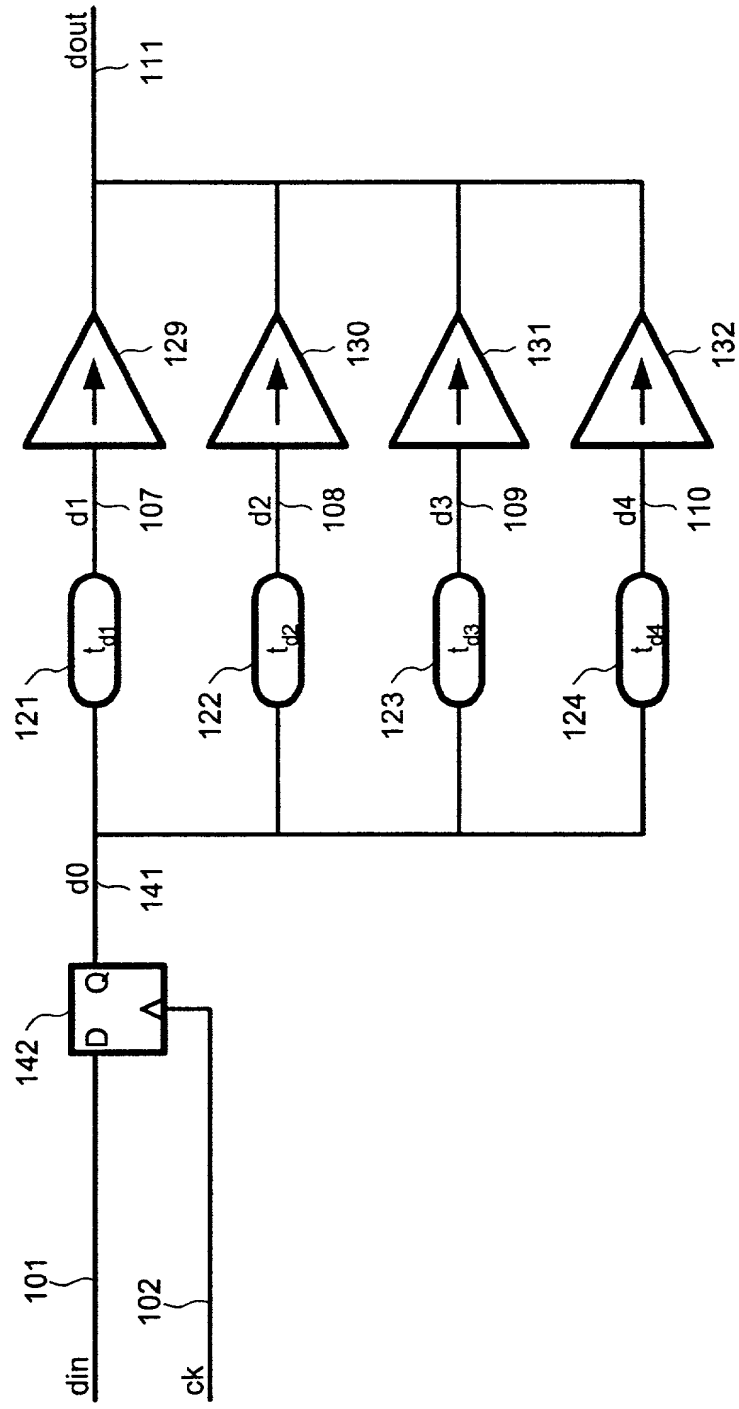


Figure 3

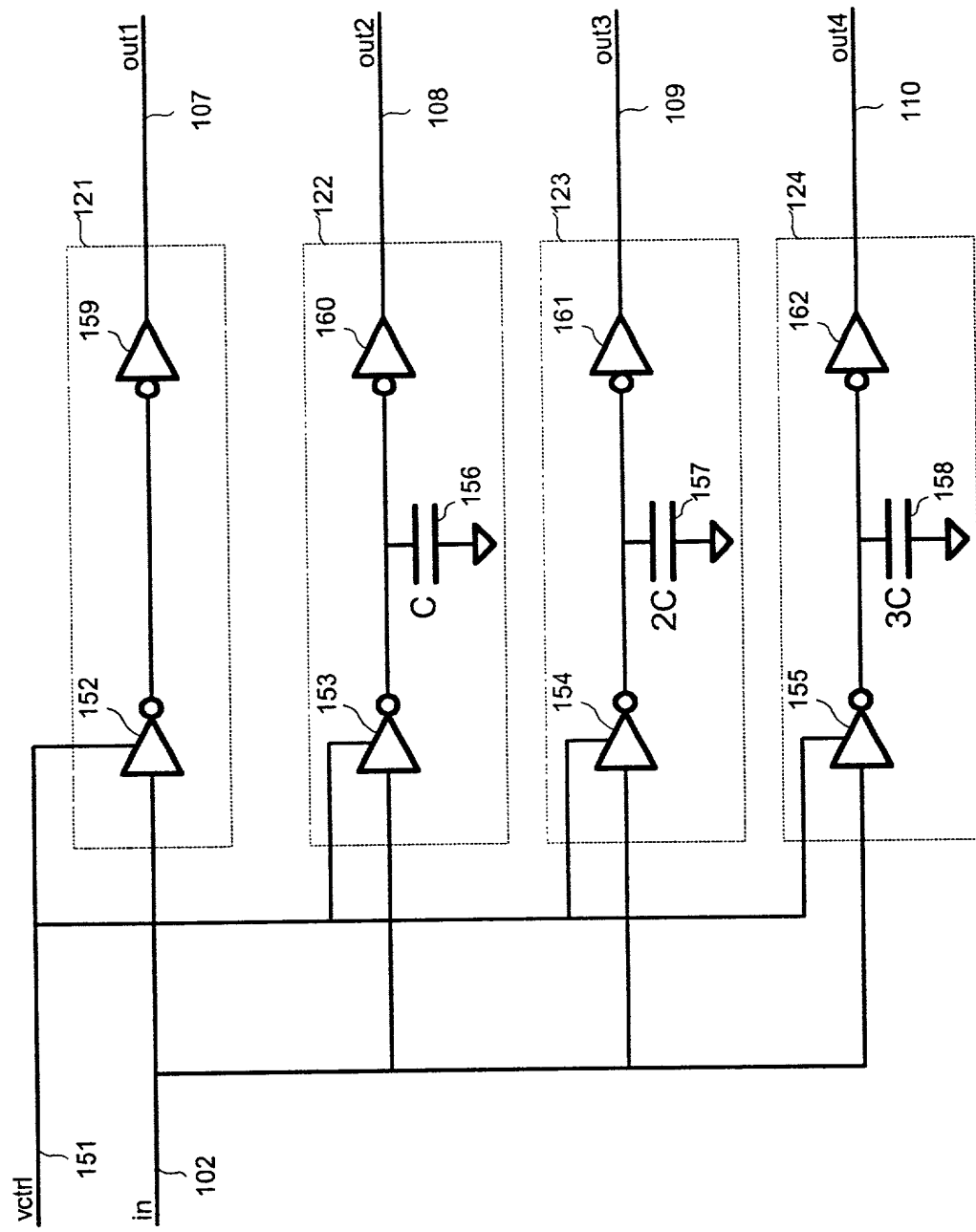


Figure 5

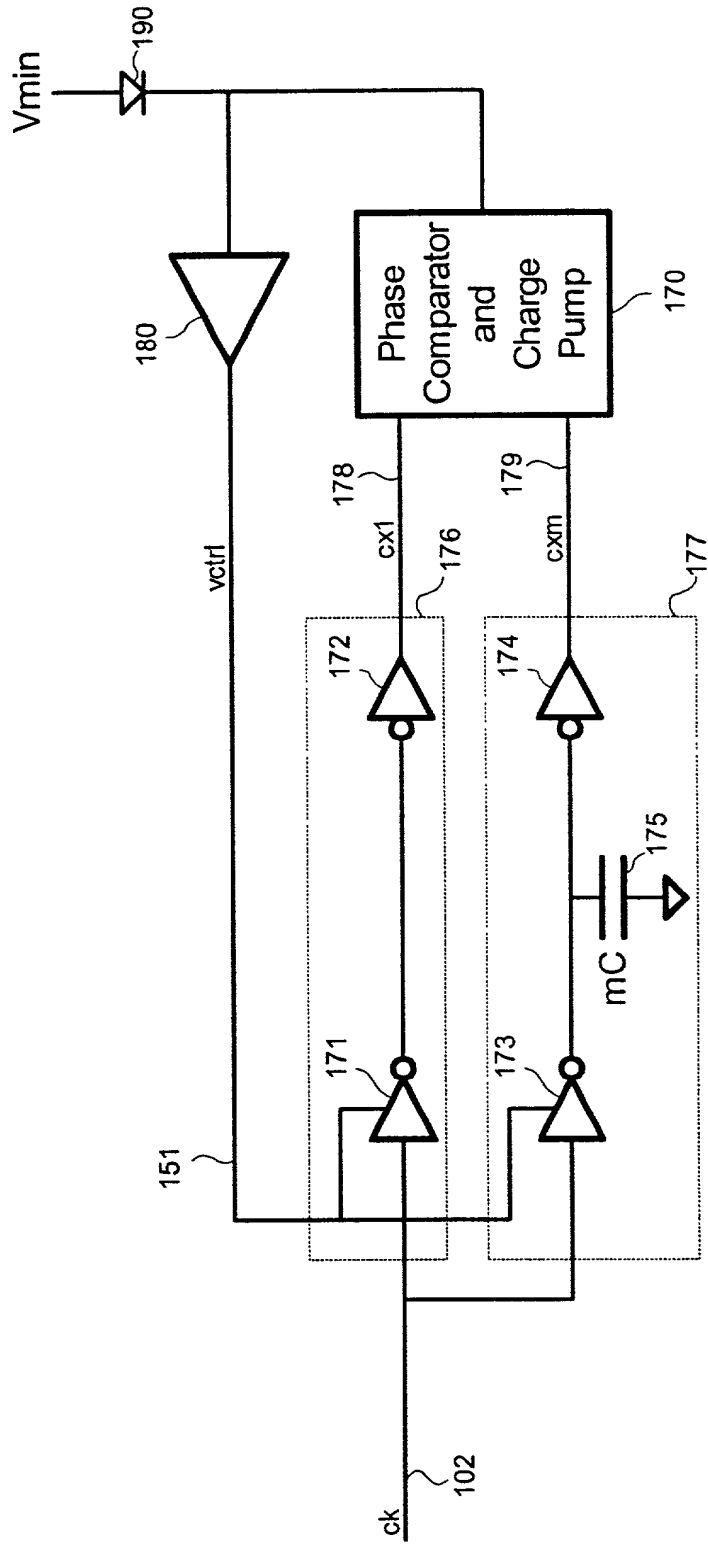


Figure 6

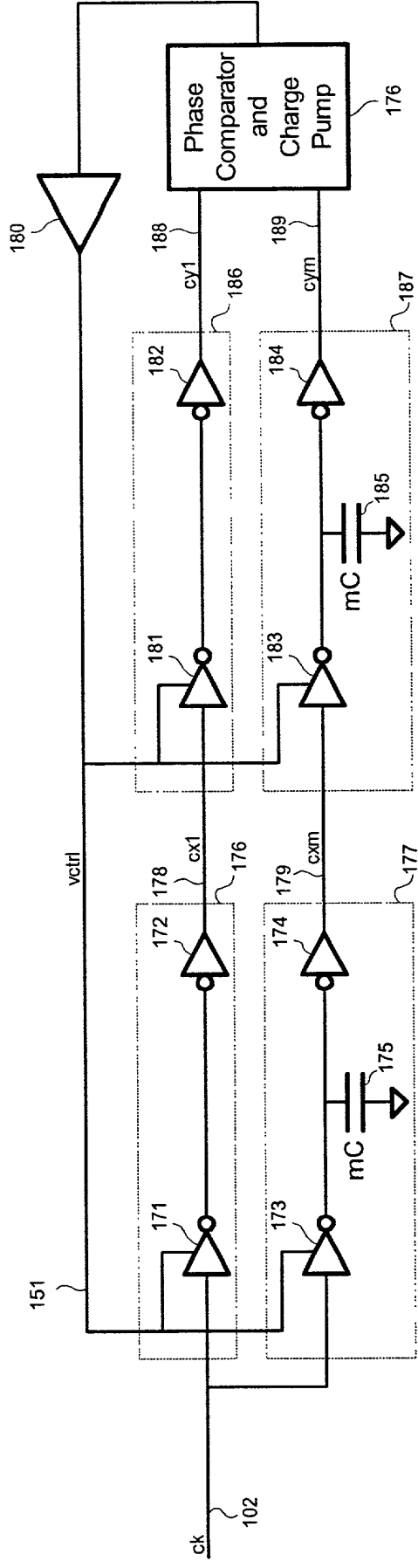


Figure 7

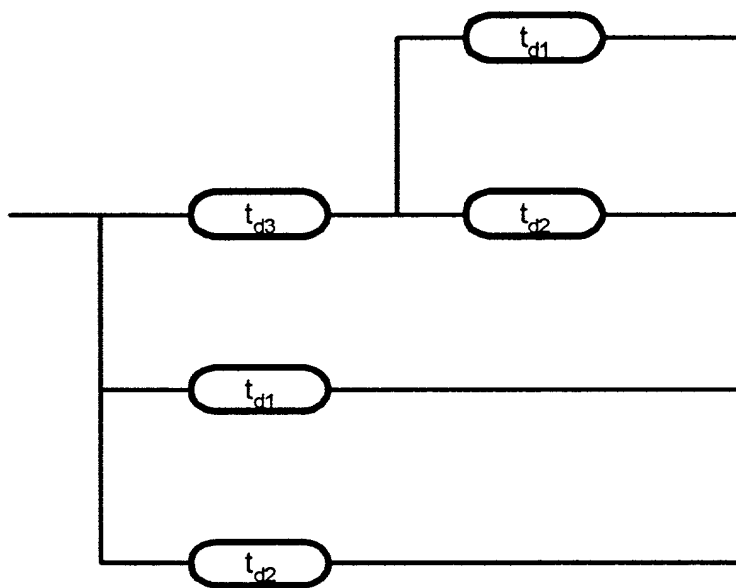


Figure 8

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Declaration for Patent Application

As a named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated next to my name;

I believe I am the original, first and sole inventor (if only one name is listed) or an original, first and joint inventor (if plural names are listed in the signatory page(s) commencing at page 3 hereof) of the subject matter which is claimed and for which a patent is sought on the invention entitled

TRANSITION-TIME CONTROL IN A HIGH-SPEED DATA TRANSMITTER

the specification of which (check one)

☒ is attached hereto.

☐ was filed on _____ as United States Application

Number or PCT International Application No. _____

and was amended on _____ (if applicable).

I hereby state that I have reviewed and understand the contents of the above-identified specification, including the claims, as amended by any amendment referred to above.

I acknowledge the duty to disclose information which is known by me to be material to patentability as defined in 37 C.F.R. §1.56.

I hereby claim foreign priority benefits under 35 U.S.C. 119(a)-(d) or 365(b) of any foreign application(s) for patent or inventor's certificate or 365(a) of any PCT international application which designated at least one country other than the United States of America, listed below and have also identified below, by checking the box, any foreign application for patent or inventor's certificate, or of any PCT international application having a filing date before that of the application on which priority is claimed:

<u>Prior Foreign Application(s)</u>			Priority Not Claimed	Certified Copy Filed?	
				YES	NO
_____ (Number)	_____ (Country)	_____ (Day/Month/Year filed)	[]	[]	[]
_____ (Number)	_____ (Country)	_____ (Day/Month/Year filed)	[]	[]	[]
_____ (Number)	_____ (Country)	_____ (Day/Month/Year filed)	[]	[]	[]

I hereby claim the benefit under 35 U.S.C. §119(e) of any United States provisional application(s) listed below.

60/181,276
(Application Number)

February 9, 2000
(Filing Date)

(Application Number)

(Filing Date)

I hereby claim the benefit under 35 U.S.C. 120 of any United States application(s), or 365(c) of any PCT international application designating the United States of America, listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States or PCT International application in the manner provided by the first paragraph of 35 U.S.C. 112, I acknowledge the duty to disclose information known by me to be material to patentability as defined in 37 C.F.R. 1.56 which became available between the filing date of the prior application and the national or PCT international filing date of this application:

_____ (Application Serial No.)	_____ (Filing date)	_____ (Status: patented, pending, abandoned)
_____ (Application Serial No.)	_____ (Filing date)	_____ (Status: patented, pending, abandoned)
_____ (Application Serial No.)	_____ (Filing date)	_____ (Status: patented, pending, abandoned)
_____ (Application Serial No.)	_____ (Filing date)	_____ (Status: patented, pending, abandoned)

As a named inventor, I hereby appoint the attorneys and/or agents associated with
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Customer No. 21005,

and _____,
to prosecute this application and to transact all business in the Patent and Trademark Office connected therewith.

Please send correspondence to:

☒ **Customer No. 21005**
HAMILTON, BROOK, SMITH & REYNOLDS, P.C.
Two Militia Drive
Lexington, MA 02421-4799

or

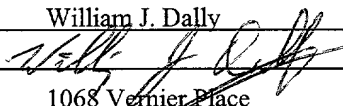
☐ **Address as follows:**

Direct telephone calls to: James M. Smith, Esq. Telephone No.: 781-861-6240
Direct facsimiles to: James M. Smith, Esq. Facsimile No.: 781-861-9540

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

Full name of sole

or first inventor William J. Dally

Inventor's Signature  Date 4/10/2000

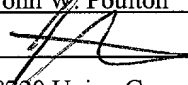
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